

**RELIABILITY MONITOR REPORT
FOR**

1.2 μm Process

Dallas Semiconductor

**4401 South Beltwood Parkway
Dallas, TX 75244-3292**

**This Report was prepared by
Dallas Semiconductor Reliability Engineering**

UNBIASED MOISTURE RESISTANCE

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
AUTOCLAVE	0326	DS1233	121C, 2 ATM STEAM, UNBIASED	168	HRS	0	
AUTOCLAVE	0340	DS1267	121C, 2 ATM STEAM, UNBIASED	168	HRS	0	
					Total:	0	

FAILURE RATE:**MTTF (YRS): 18801****FITS: 6.1**